## MOSFET – Power, Dual, P-Channel, μCool, UDFN, 2.0x2.0x0.55 mm -20 V, -5.6 A

#### **Features**

- UDFN Package with Exposed Drain Pads for Excellent Thermal Conduction
- Low R<sub>DS(on)</sub>
- Low Profile UDFN 2.0x2.0x0.55 mm for Board Space Saving
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **Applications**

- High Side Load Switch
- Reverse Current Protection
- Battery Switch
- Optimized for Power Management Applications for Portable Products, such as Cell Phones, PMP, DSC, GPS, and others

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter			Symbol	Value	Units
Drain-to-Source Voltage			$V_{DSS}$	-20	V
Gate-to-Source Vol	tage		V <sub>GS</sub>	±8.0	٧
Continuous Drain Current (Note 1)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	-4.4	Α
Current (Note 1)	Siale	T <sub>A</sub> = 85°C		-3.2	
	t ≤ 5 s	T <sub>A</sub> = 25°C		-5.6	
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.4	W
	t ≤ 5 s	T <sub>A</sub> = 25°C		2.2	
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-2.8	Α
Current (Note 2)	urrent (Note 2) State			-2.0	
Power Dissipation (Note 2) T <sub>A</sub> = 25°C		$P_{D}$	0.5	W	
Pulsed Drain Current tp = 10 μs		I <sub>DM</sub>	-13	Α	
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
ESD (HBM, JESD22-A114) (MM, JESD22-A114)			V <sub>ESD</sub>	1400 200	V
Source Current (Body Diode) (Note 2)			I <sub>S</sub>	-1.0	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

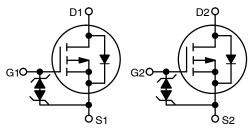
 Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces) based on both FETs on.



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MOSFET				
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX		
-20 V	50 mΩ @ -4.5 V			
	70 mΩ @ –2.5 V	-5.6 A		
	115 mΩ @ –1.8 V	0.071		
	175 mΩ @ –1.5 V			



P-Channel MOSFET

## MARKING DIAGRAM



UDFN6 CASE 517BF μCOOL™



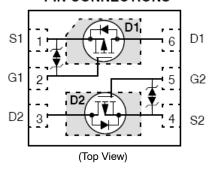
AA = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

### PIN CONNECTIONS



## ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

2. Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 1 oz. Cu based on both FETs on.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient – Steady State (Note 3)	$R_{\theta JA}$	91	°C/W
Junction-to-Ambient – t ≤ 5 s (Note 3)	$R_{\theta JA}$	57	
Junction-to-Ambient – Steady State min Pad (Note 4)	$R_{\theta JA}$	228	

#### **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Co	ondition	Min	Тур	Max	Units
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = -250 μA	A, ref to 25°C		-13		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -20 V	T <sub>J</sub> = 25°C			-1.0	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±5.0 V				±5.0	μΑ
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$	I <sub>D</sub> = -250 μA	-0.4		-1.0	V
Negative Threshold Temp. Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				3.0		mV/°(
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5	V, I <sub>D</sub> = -4.0 A		37	50	mΩ
		V <sub>GS</sub> = −2.5 '	V, I <sub>D</sub> = -3.0 A		46	70	
		$V_{GS} = -1.8 \text{ V}, I_D = -2.0 \text{ A}$			63	115	
		$V_{GS} = -1.5 \text{ V}, I_D = -1.0 \text{ A}$			86	175	
Forward Transconductance	9FS	$V_{DS} = -5.0 \text{ V}, I_D = -3.0 \text{ A}$			16		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz,} $ $V_{DS} = -15 \text{ V}$			920		pF
Output Capacitance	C <sub>OSS</sub>				85		
Reverse Transfer Capacitance	C <sub>RSS</sub>	20			80		
Total Gate Charge	$Q_{G(TOT)}$				10.4		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = -4.5 V_{s}$	V <sub>DS</sub> = -15 V; -3.0 A		0.5		
Gate-to-Source Charge	$Q_{GS}$	I <sub>D</sub> = -	-3.0 A		1.2		
Gate-to-Drain Charge	$Q_{GD}$				3.0		
SWITCHING CHARACTERISTICS, VG	<b>S</b> = <b>4.5 V</b> (Note 6	5)					
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} = -15 \text{ V},$ $I_{D} = -3.0 \text{ A}, R_{G} = 1 \Omega$			7.0		ns
Rise Time	t <sub>r</sub>				12		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				39		
Fall Time	t <sub>f</sub>				30		
DRAIN-SOURCE DIODE CHARACTEI	RISTICS						
Forward Diode Voltage	VSD	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		-0.67	-1.0	V
$I_{S} = -1.0 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$	T <sub>J</sub> = 125°C		-0.56				

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces) based on both FETs on.
   Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces) based on both FETs on.
   Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

- 6. Switching characteristics are independent of operating junction temperatures.

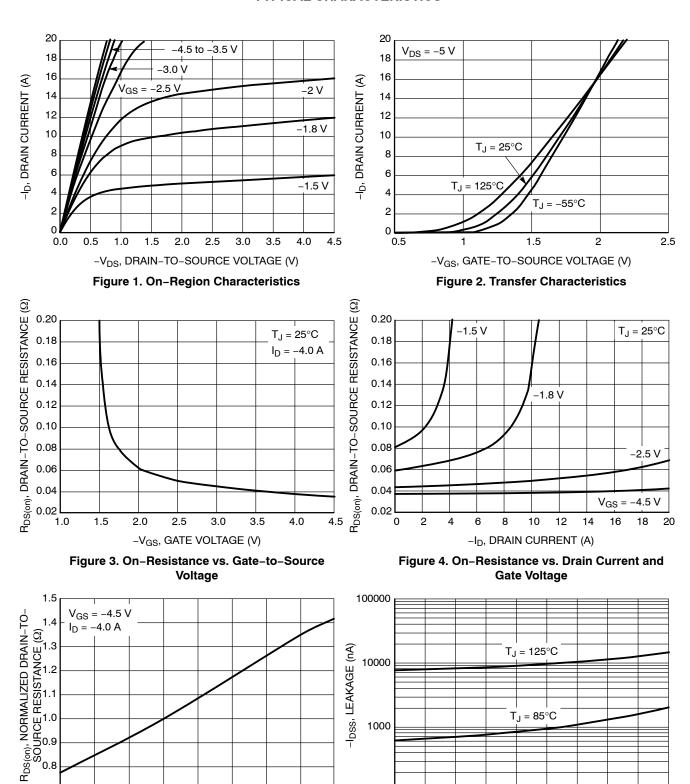
## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

	, -	• • •				
Parameter	Symbol	Test Condition	Min	Тур	Max	Units
DRAIN-SOURCE DIODE CHARACTERISTICS						
Reverse Recovery Time	t <sub>RR</sub>			12.1		ns
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dis/dt = 100 A/μs,		6.4		
Discharge Time	t <sub>b</sub>	$V_{GS}$ = 0 V, dis/dt = 100 A/ $\mu$ s, $I_S$ = -1.0 A		5.7		
Reverse Recovery Charge	$Q_{RR}$			4.0		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces) based on both FETs on.
   Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 1 oz. Cu based on both FETs on.
   Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
   Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



T<sub>J</sub>, JUNCTION TEMPERATURE (°C) Figure 5. On-Resistance Variation with **Temperature** 

0.7

-50

-25

Figure 6. Drain-to-Source Leakage Current vs. Voltage

-V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

#### TYPICAL CHARACTERISTICS

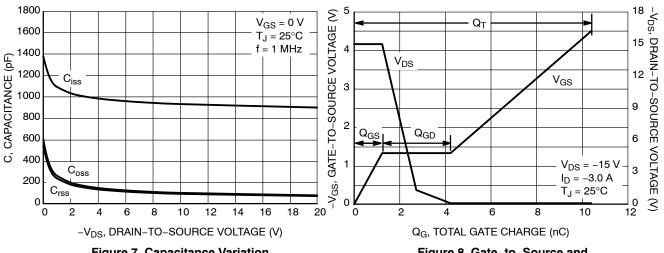


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

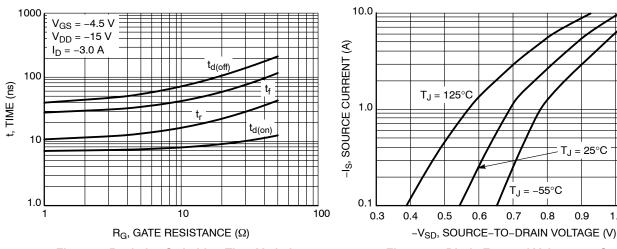


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

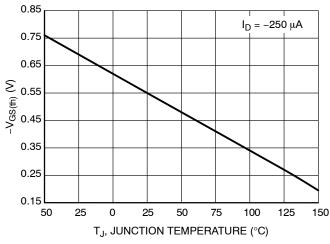


Figure 11. Threshold Voltage

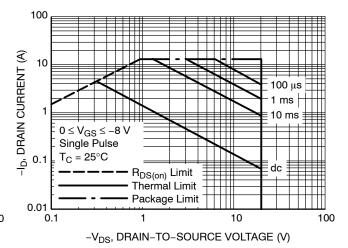


Figure 12. Maximum Rated Forward Biased Safe Operating Area

## **TYPICAL CHARACTERISTICS**

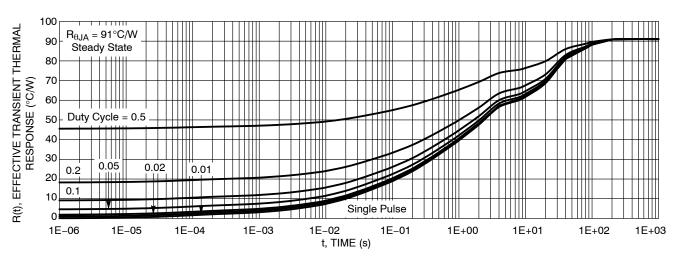


Figure 13. FET Thermal Response

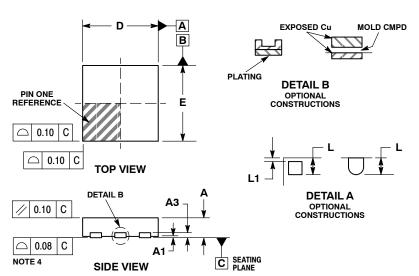
## **DEVICE ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTLUD3A50PZTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUD3A50PZTBG	UDFN6 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

#### UDFN6 2x2, 0.65P CASE 517BF ISSUE B

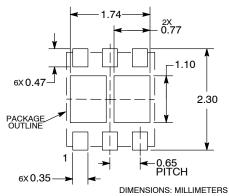


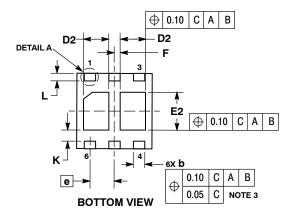
#### INTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION & APPLIES TO PLATED
- TERMINAL AND IS MEASURED BETWEEN
  0.15 AND 0.30 mm FROM THE TERMINAL TIP.
  4. COPLANARITY APPLIES TO THE EXPOSED
  PAD AS WELL AS THE TERMINALS.

	MILLIMETERS				
DIM	MIN	MAX			
Α	0.45	0.55			
A1	0.00	0.05			
A3	0.13 REF				
b	0.25	0.35			
D	2.00 BSC				
D2	0.57	0.77			
E	2.00 BSC				
E2	0.90	1.10			
е	0.65 BSC				
F	0.15 BSC				
K	0.25 REF				
L	0.20	0.30			
L1		0.10			

# RECOMMENDED MOUNTING FOOTPRINT





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